



FORM PTO-1449 (Modified) (REV. 7-80)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO.: <b>LECHNER 2 PCT</b>		SERIAL NO.: <b>10/511,219</b>		
LIST OF REFERENCES CITED BY APPLICANT  (Use several sheets if necessary)				APPLICANT: <b>Martin LECHNER</b>				
				FILING DATE: <b>OCTOBER 13, 2004</b>		GROUP: <b>3747</b>		
<b>U.S. PATENT DOCUMENTS</b>								
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
	AA							
	AB							
	AC							
	AD							
	AE							
	AF							
	AG							
	AH							
	AI							
	AJ							
	AK							
<b>FOREIGN PATENT DOCUMENTS</b>								
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
	AL	JP 2,241,925	9/1990	JAPAN Abstract in English				
	AM	DE 3,737,820	8/1989	GERMANY Abstract in English				
	AN	DE 19,830,575	1/2000	GERMANY Abstract in English				
	AO							
	AP							
<b>OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)</b>								
	AR	International Search Report in English						
EXAMINER <b>KWON</b>				DATE CONSIDERED <b>1/31/2006</b>				
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								

10/511219

DT05 Rec'd PCPTD of 13 OCT 2004

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				FILING DATE:		GROUP:		
U.S. PATENT DOCUMENTS								
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
OK ✓	AA	5105784	4/1992	McFarlane et al				
OK ✓	AB	2002/005185	1/17/2002	Schatz				
FOREIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
OK ✓	AC	DE 198 09 919	2/1999	Germany				
✓	AD	DE 198 30 575	1/2000	Germany				
✓	AE	DE 199 51 085	4/2001	Germany				
✓	AF	DE 25 53 293	6/1977	Germany				
✓	AG	DE 26 21 362	11/1977	Germany (Intl. Srch. Rep.) + page 1				
✓	AH	DE 29 38 118	4/1981	Germany (Intl. Srch. Rep.)				
✓	AI	DE 35 38 589	5/1987	Germany				
✓	AJ	DE 43 06 431	7/1994	Germany				
✓	AK	EP 0 459 964	12/1991	European (Intl. Srch. Rep.)				
✓	AL	EP 0 713 720	2/2001	European				
✓	AM	EP 1 229 985	8/2003	European				
✓	AN	EP 1 260 260	11/2002	European				
✓	AO	JP 2 241925	9/1990	Japan w/Engl. Abstract pg. 2				
OK ✓	AP	WO 01 07141	2/2001	International				
OK ✓	AQ	DE 37 37 820	8/1989	Germany				
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)								
	AR							
	AS							
EXAMINER Kwon				DATE CONSIDERED 1/31/2006				
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